

Notice of References Cited

Application/Control No. 09/864,107	Reexamination VAN LIERE,	on
Examiner	Art Unit	
Jin-Cheng Wang	2672	Page 1 of 1

U.S. PATENT DOCUMENTS

*		Document Number Country Code-Number-Kind Code	Date MM-YYYY	Name	Classification
	Α	US-5,247,614	09-1993	Eagen et al.	709/203
	В	US-			
	С	US-			
	D	US-			
	E	US-			
	F:	US-			
7	G	US-		/	
	н	US-			
	ı	US-		,	
	J	US-			
	к	US-		,	
	L	US-			
	М	US-			

FOREIGN PATENT DOCUMENTS

*		Document Number Country Code-Number-Kind Code	Date MM-YYYY	Country	Name	Classification
	Ν					
	0					
	Р					
	ď					
	R					
	S					
	Т					

NON-PATENT DOCUMENTS

	NON-FATENT DOCUMENTS					
*		Include as applicable: Author, Title Date, Publisher, Edition or Volume, Pertinent Pages)				
	U					
	V		· · ·			
	w					
	x	/				

*A copy of this reference is not being furnished with this Office action. (See MPEP § 707.05(a).) Dates in MM-YYYY format are publication dates. Classifications may be US or foreign.

